

RESOLUTION BOUNDS TO IMAGING WITH NEGATIVE-REFRACTIVE-INDEX TRANSMISSION-LINE LENSES

Anthony Grbic, George V. Eleftheriades

Dept. of Electrical and Computer Engineering, 10 King's College Road, University of Toronto, Toronto, ON M5S 3G4, Canada

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Abstract: eleftheriades15557

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The perfect lens concept proposed by John Pendry in 2000 has captured the imagination of the scientific and technical communities alike [1]. Since then, numerous questions were raised concerning the issue of how close one can approach the perfect lens concept in practice. In a recent experiment, a negative-refractive-index (NRI) transmission-line (TL) lens was used to demonstrate imaging beyond the diffraction limit at microwave frequencies [2]. This experimental device consisted of a NRI region comprising microstrip lines loaded with series capacitors and shunt inductors. The so created NRI region was sandwiched between two dense microstrip meshes acting as parallel-plate waveguides. Using this NRI-TL lens, a resolution of  $\lambda/6$  was achieved as opposed to the diffraction-limited resolution which would have been  $\lambda/2$  [2]. Although the achieved resolution beats the diffraction limit, it does not correspond to perfect imaging. In this paper, we will discuss the practical resolution bounds of the experimental lenses in [2] due to material and mismatch losses.

A key result of our analysis is that the resolution is logarithmically bounded by the losses on the loading series capacitors. Specifically, the maximum resolved transverse wavenumber  $k_x$  is determined by,

$$R = \frac{k_x}{k_o} = \frac{\ln(Q_c)}{k_o d}$$

where  $k_o d$  is the electrical thickness of the lens in radians and  $Q_c$  is the quality factor of the loading series capacitors.

[1] J. B. Pendry, Negative refraction makes a perfect lens, Phys. Rev. Lett., vol. 85, no. 18, pp. 3966-3969, Oct. 2000.

[2] A. Grbic and G.V. Eleftheriades, Overcoming the diffraction limit with a planar left-handed transmission-line lens. Phys. Rev. Lett., vol. 92, no. 11, pp. 117403, March 19, 2004.

1. (a) George Eleftheriades  
George V. Eleftheriades  
Toronto, ON  
M5S 3G4 Canada  
gelefth@waves.utoronto.ca  
(b) 416-946-3564  
(c) 416-971-2286
2. B - Fields and Waves
3. (a) Metamaterials and Other  
Complex Materials for  
Radio Frequency  
Applications
4. I - Invited Paper, Program  
chair: John Volakis and  
George V. Eleftheriades
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